

<b>Notice of References Cited</b>	Application/Control No. 10/590,298		Applicant(s)/Patent Under Reexamination PLEE ET AL.	
	Examiner NGUYEN T. HA		Art Unit 2831	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,088,572	08-2006	Yoshida et al.	361/504
*	B	US-6,882,517	04-2005	Tano et al.	361/502
*	C	US-6,547,990	04-2003	Shinozaki et al.	252/502
*	D	US-6,118,650	09-2000	Maeda et al.	361/508
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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